## Notice of References Cited Application/Control No. O9/941,142 Examiner Oavid J. Huisman Applicant(s)/Patent Under Reexamination WAH CHAN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,420,991	05-1995	Konigsfeld et al.	711/150
*	В	US-6,141,734	10-2000	Razdan et al.	711/144
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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